

<b>Notice of References Cited</b>	Application/Control No. 10/715,045	Applicant(s)/Patent Under Reexamination SENDYK ET AL.	
	Examiner YUWEN PAN	Art Unit 2618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,319,659	01-2008	Tsuie, Yih-Ming	370/203
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	D	US-			
	E	US-			
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